



SGS-THOMSON
MICROELECTRONICS

HCC4073B/81B/82B
HCF4073B/81B/82B

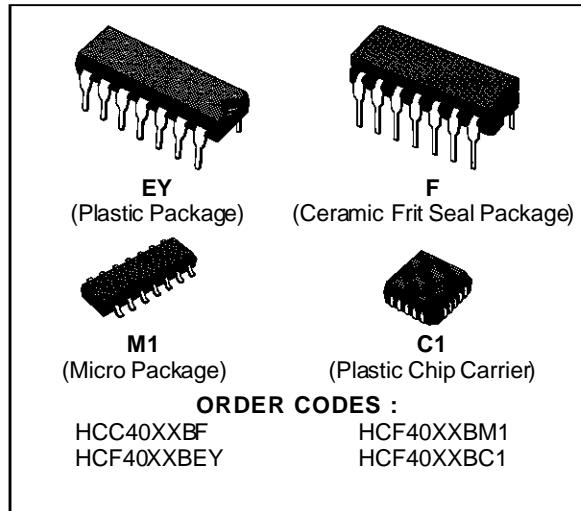
AND GATES

4073B TRIPLE 3-INPUT AND GATE

4081B QUAD 2-INPUT AND GATE

4082B DUAL 4-INPUT AND GATE

- MEDIUM SPEED OPERATION – $t_{PLH} = 85\text{ns}$ (typ.) ; $t_{PHL} = 65\text{ns}$ (typ.) AT 10V
- QUIESCENT CURRENT SPECIFIED TO 20V FOR HCC DEVICE
- 5V, 10V, AND 15V PARAMETRIC RATINGS
- INPUT CURRENT OF 100nA AT 18V AND 25°C FOR HCC DEVICE
- 100% TESTED FOR QUIESCENT CURRENT
- MEETS ALL REQUIREMENTS OF JEDEC TEMPORARY STANDARD N°13A, "STANDARD SPECIFICATIONS FOR DESCRIPTION OF "B" SERIES CMOS DEVICES"



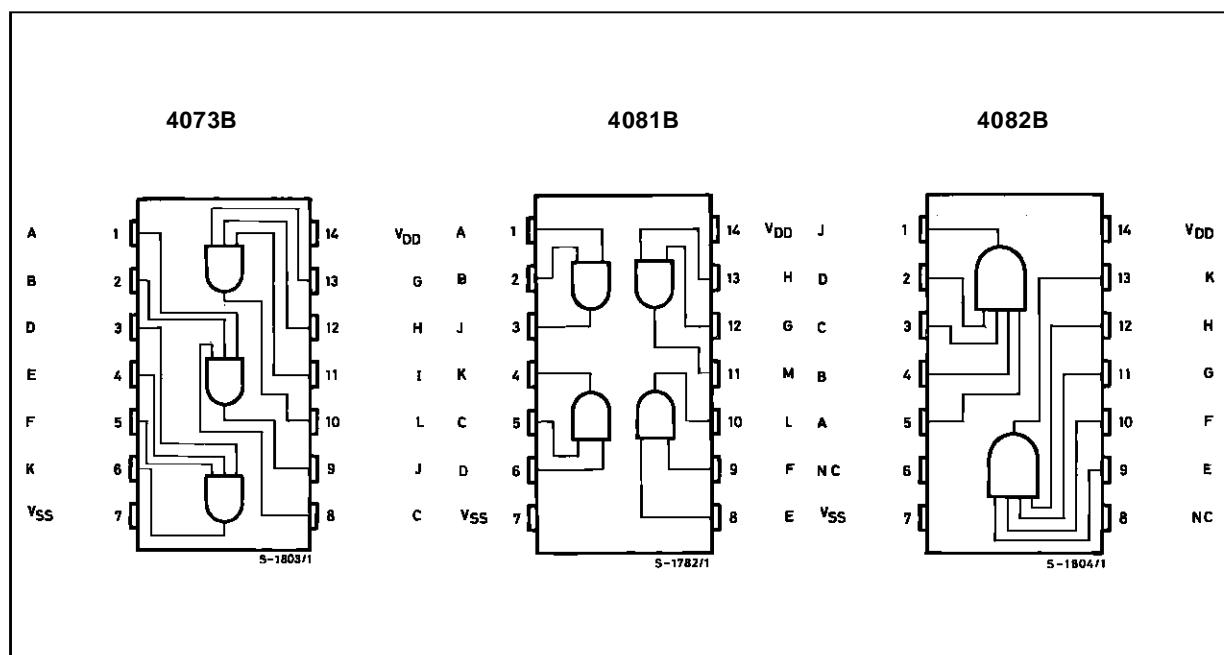
DESCRIPTION

The **HCC4073B**, **HCC4081B** and **HCC4082B** (extended temperature range) and the **HCF4073B**, **HCF4081B** and **HCF4082B** (intermediate temperature range) are monolithic integrated circuits available in 14-lead dual in-line plastic or ceramic package and plastic micro package.

able in 14-lead dual in-line plastic or ceramic package and plastic micro package.

The **HCC/HCF4073B**, **4081B** and **4082B** AND gates provide the system designer with direct im-

CONNECTION DIAGRAM



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V_{DD}^*	Supply Voltage : HCC Types HCF Types	– 0.5 to + 20 – 0.5 to + 18	V V
V_i	Input Voltage	– 0.5 to V_{DD} + 0.5	V
I_I	DC Input Current (any one input)	± 10	mA
P_{tot}	Total Power Dissipation (per package)		

STATIC ELECTRICAL CHARACTERISTICS (continued)

Symbol	Parameter	Test Conditions				Value						Unit	
		V_I (V)	V_o (V)	$ I_o $ (μ A)	V_{DD} (V)	T_{Low}^*		25 °C			T_{High}^*		
						Min.	Max.	Min.	Typ.	Max.	Min.	Max.	
V_{IH}	Input High Voltage		0.5/4.5	< 1	5	3.5		3.5			3.5		V
			1/9	< 1	10	7		7			7		
			1.5/13.5	< 1	15	11		11			11		
V_{IL}	Input Low Voltage		4.5/0.5	< 1	5		1.5			1.5		1.5	V
			9/1	< 1	10		3			3		3	
			13.5/1.5	< 1	15		4			4		4	
I_{OH}	Output Drive Current	HCC Types	0/ 5	2.5		5	- 2		- 1.6	- 3.2		- 1.15	mA
			0/ 5	4.6		5	- 0.64		- 0.51	- 1		- 0.36	
			0/10	9.5		10	- 1.6		- 1.3	- 2.6		- 0.9	
			0/15	13.5		15	- 4.2		- 3.4	- 6.8		- 2.4	
		HCF Types	0/ 5	2.5		5	- 1.53		- 1.36	- 3.2		- 1.1	
			0/ 5	4.6		5	- 0.52		- 0.44	- 1		- 0.36	
			0/10	9.5		10	- 1.3		- 1.1	- 2.6		- 0.9	
			0/15	13.5		15	- 3.6		- 3.0	- 6.8		- 2.4	
			0/ 5	0.4		5	0.64		0.51	1		0.36	
			0/10	0.5		10	1.6		1.3	2.6		0.9	
I_{OL}	Output Sink Current	HCC Types	0/15	1.5		15	4.2		3.4	6.8		2.4	mA
			0/ 5	0.4		5	0.52		0.44	1		0.36	
			0/10	0.5		10	1.3		1.1	2.6		0.9	
		HCF Types	0/15	1.5		15	3.6		3.0	6.8		2.4	
			0/ 5	0.4		5	0.64		0.51	1		0.36	
			0/10	0.5		10	1.6		1.3	2.6		0.9	
I_{IH}, I_{IL}	Input Leakage Current	HCC Types	0/18	Any Input	18		± 0.1		$\pm 10^{-5}$	± 0.1		± 1	μ A
			0/15		15		± 0.3		$\pm 10^{-5}$	± 0.3		± 1	
C _I	Input Capacitance		Any Input						5	7.5			pF

* $T_{Low} = - 55^\circ\text{C}$ for HCC device : $- 40^\circ\text{C}$ for HCF device.

* $T_{High} = + 125^\circ\text{C}$ for HCC device : $+ 85^\circ\text{C}$ for HCF device.

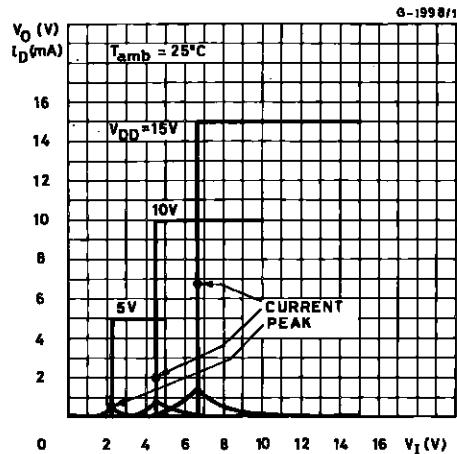
The Noise Margin for both "1" and "0" level is : 1V min. with $V_{DD} = 5\text{V}$, 2V min. with $V_{DD} = 10\text{V}$, 2.5V min. with $V_{DD} = 15\text{V}$.

DYNAMIC ELECTRICAL CHARACTERISTICS ($T_{amb} = 25^\circ\text{C}$, $C_L = 50\text{pF}$, typical temperature coefficient for all V_{DD} values is 0.3%/°C, all input rise and fall times = 20ns, $R_L = 200\text{k}\Omega$)

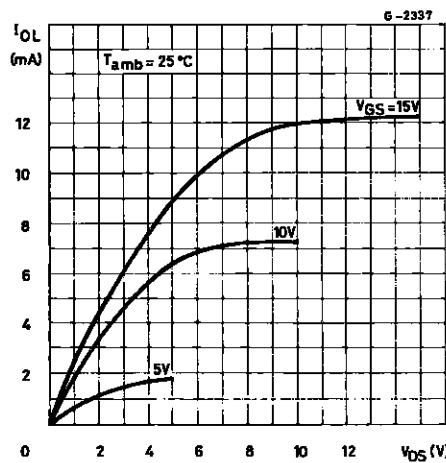
Symbol	Parameter	Test Conditions			Value			Unit	
		V_{DD} (V)	Min.	Typ.	Max.				
t_{PHL}, t_{PLH}	Propagation Delay Time		5			125	250	ns	
			10			60	125		
			15			45	90		
t_{TLH}, t_{THL}	Transition Time		5			100	200	ns	
			10			50	100		
			15			40	80		

HCC/HCF4073B/4081B/4082B

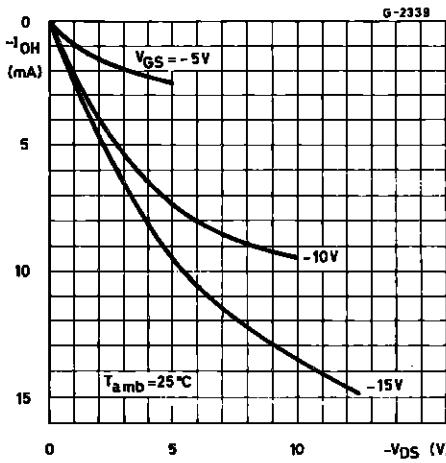
Typical Voltage and Current Transfer Characteristics.



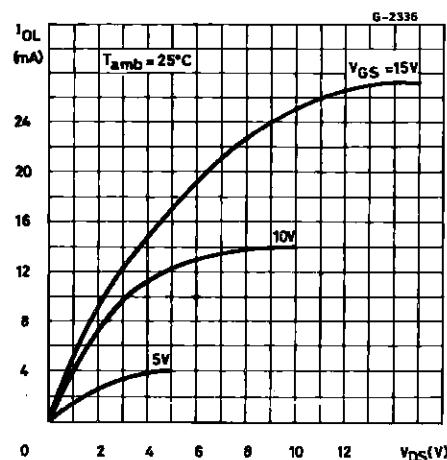
Minimum Output Low (sink) Current Characteristics.



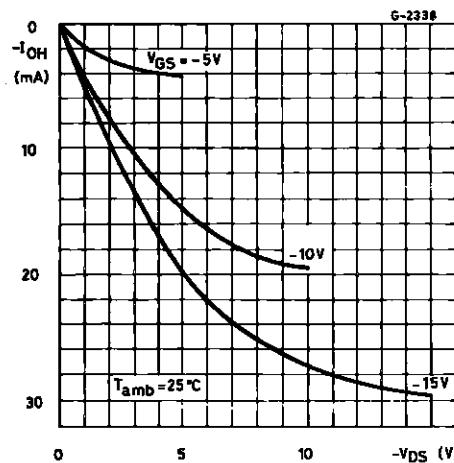
Minimum Output High (source) Current Characteristics.



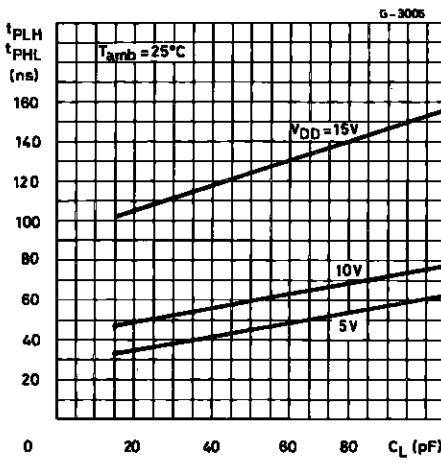
Typical Output Low (sink) Current .



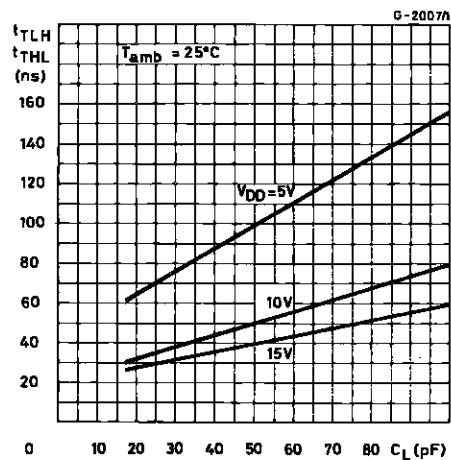
Typical Output High (source) Current Characteristics.



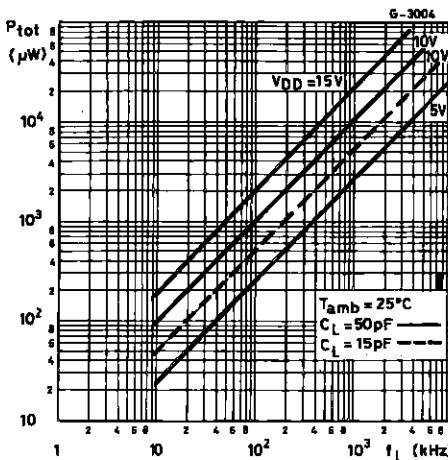
Typical Propagation Delay Time vs. Load Capacitance.



Typical Transition Time vs. Load Capacitance.

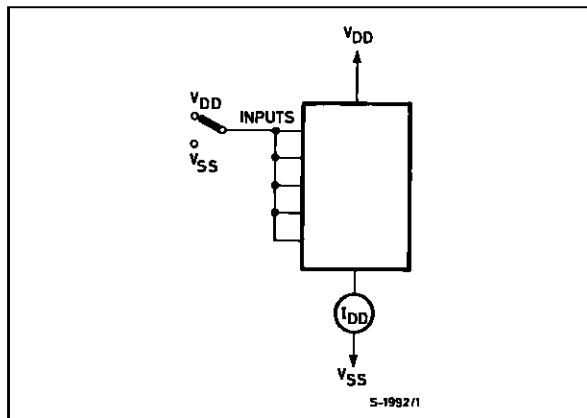


Typical Dynamic Power Dissipation per Gate vs. Frequency.

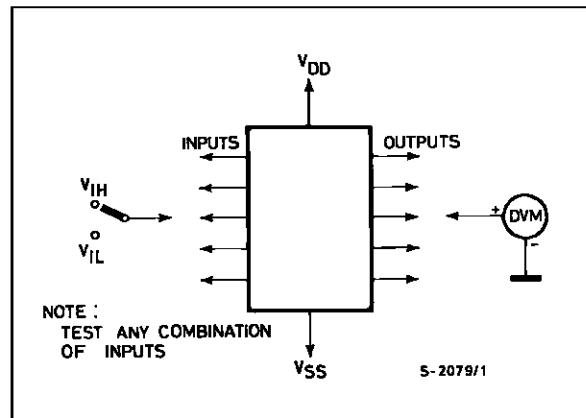


TEST CIRCUITS

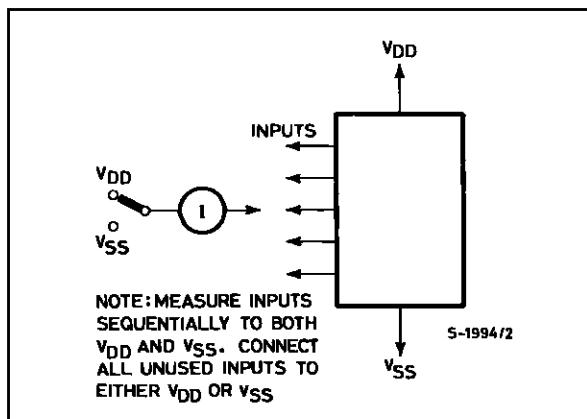
Quiescent Device Current.



Input Voltage.

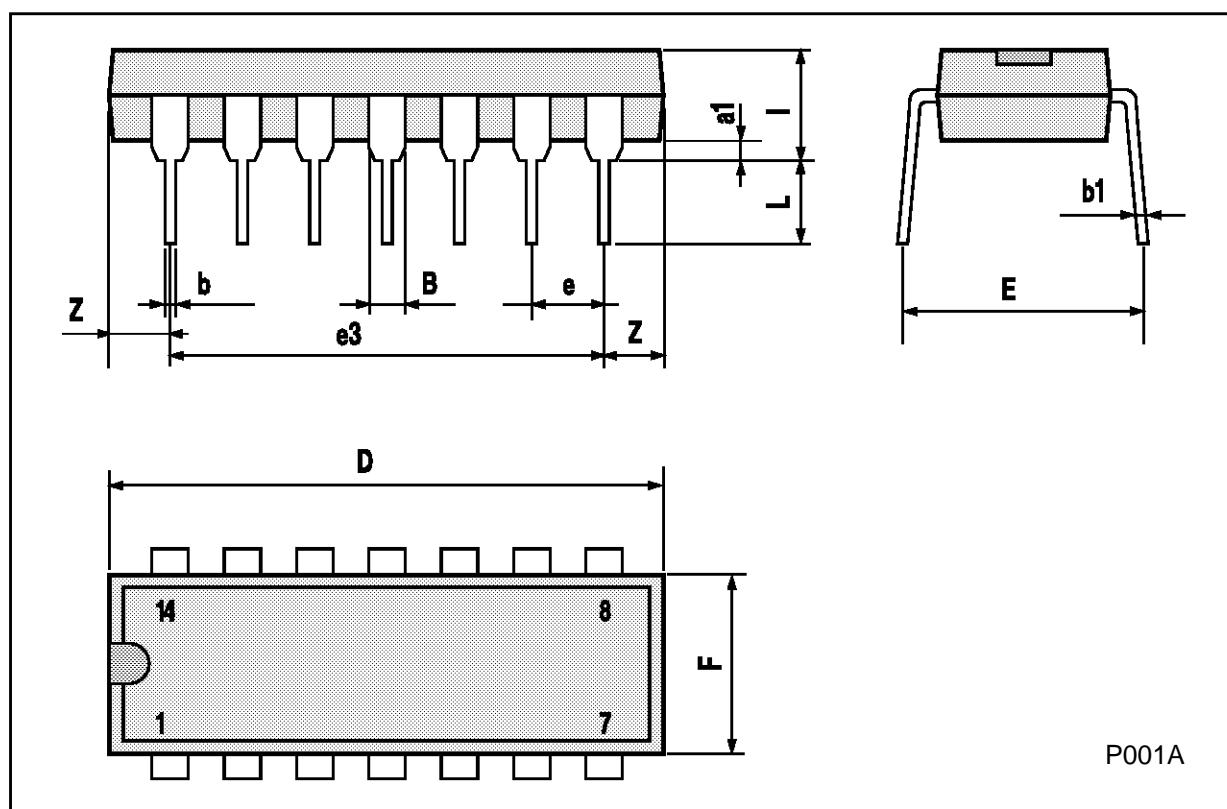


Input Leakage Current.



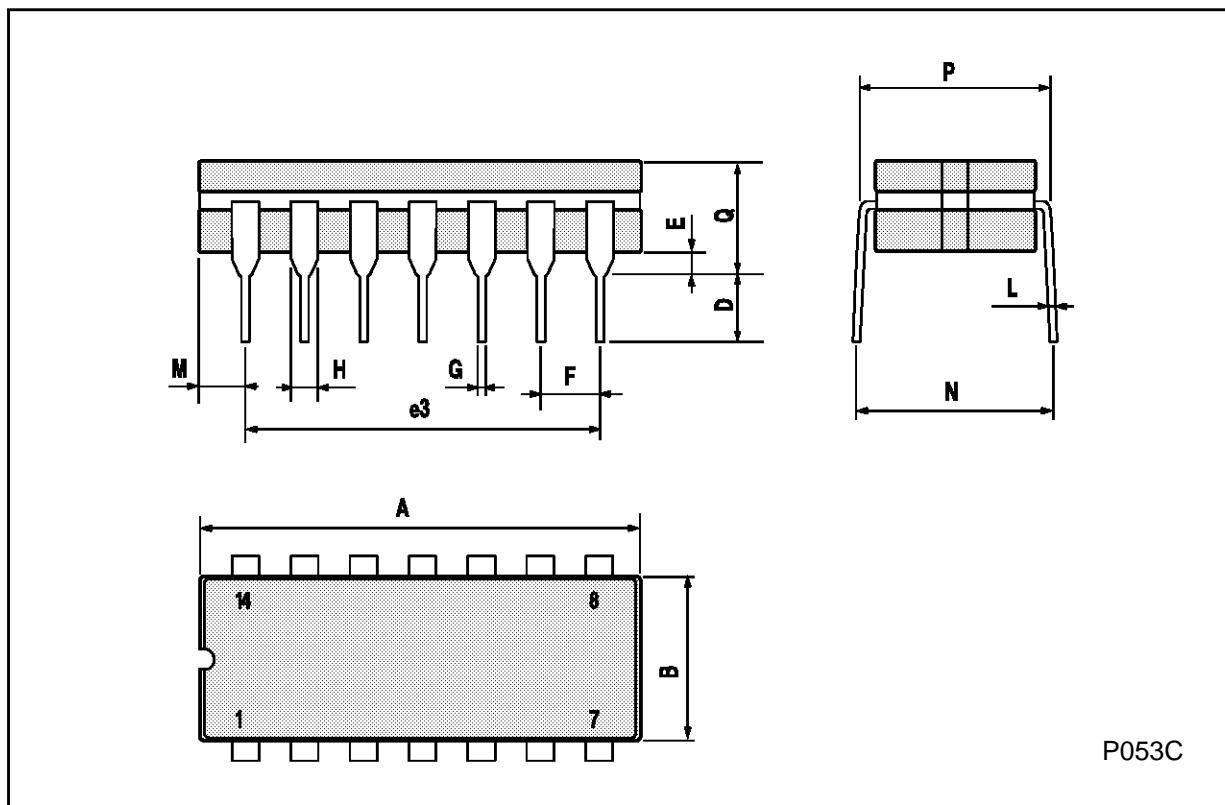
Plastic DIP14 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
a1	0.51			0.020		
B	1.39		1.65	0.055		0.065
b		0.5			0.020	
b1		0.25			0.010	
D			20			0.787
E		8.5			0.335	
e		2.54			0.100	
e3		15.24			0.600	
F			7.1			0.280
I			5.1			0.201
L		3.3			0.130	
Z	1.27		2.54	0.050		0.100



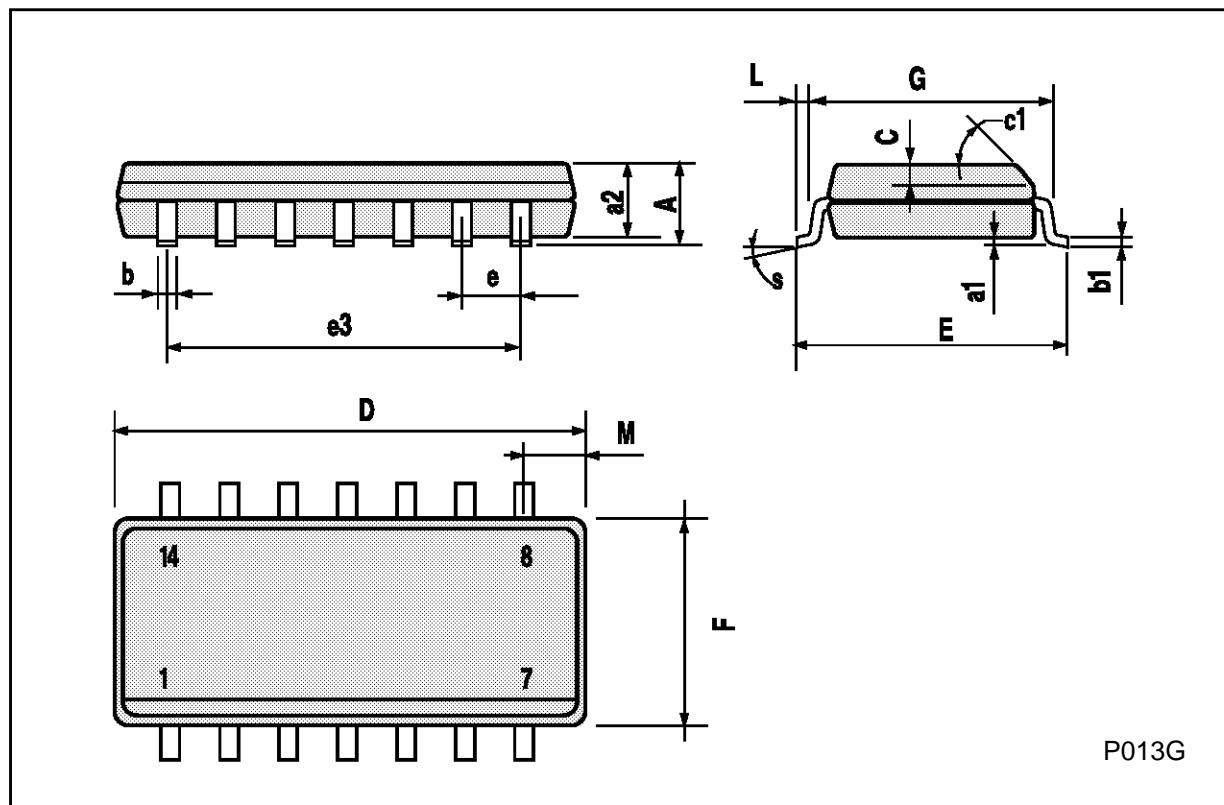
Ceramic DIP14/1 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			20			0.787
B			7.0			0.276
D		3.3			0.130	
E	0.38			0.015		
e3		15.24			0.600	
F	2.29		2.79	0.090		0.110
G	0.4		0.55	0.016		0.022
H	1.17		1.52	0.046		0.060
L	0.22		0.31	0.009		0.012
M	1.52		2.54	0.060		0.100
N			10.3			0.406
P	7.8		8.05	0.307		0.317
Q			5.08			0.200



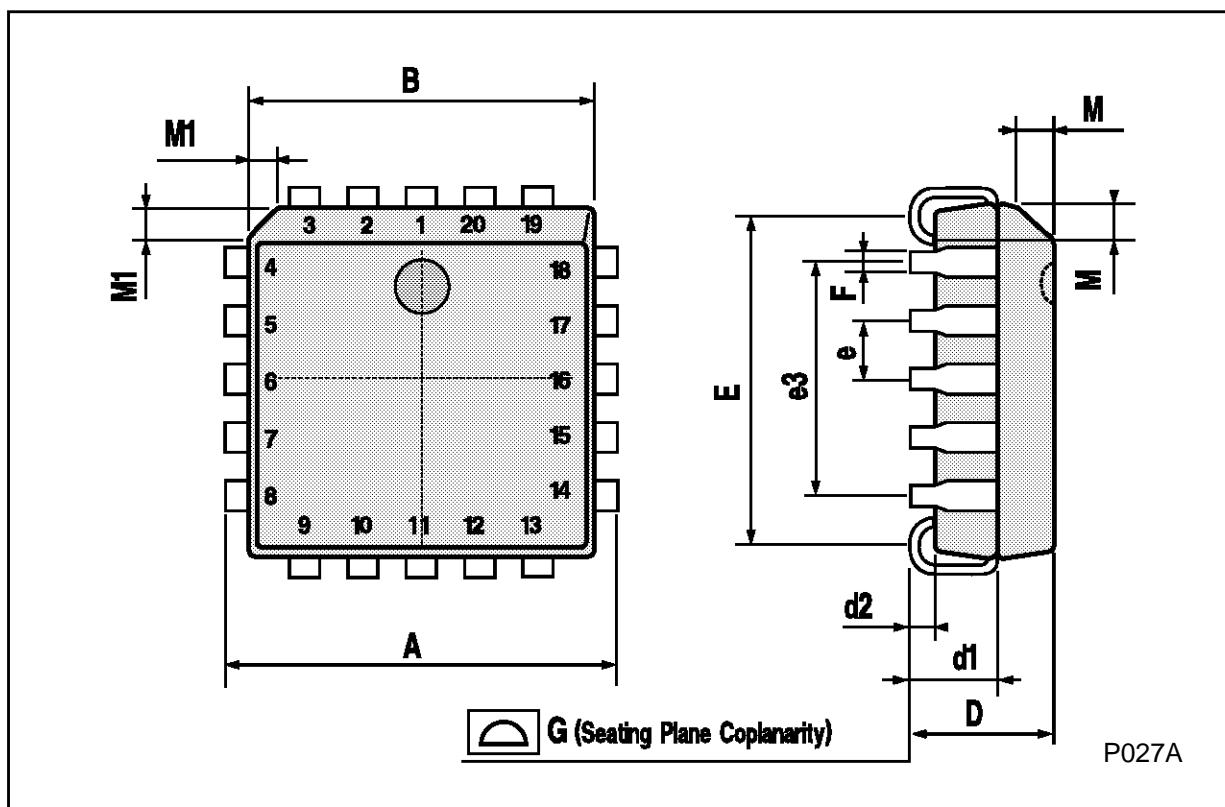
SO14 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.2	0.003		0.007
a2			1.65			0.064
b	0.35		0.46	0.013		0.018
b1	0.19		0.25	0.007		0.010
C		0.5			0.019	
c1		45° (typ.)				
D	8.55		8.75	0.336		0.344
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		7.62			0.300	
F	3.8		4.0	0.149		0.157
G	4.6		5.3	0.181		0.208
L	0.5		1.27	0.019		0.050
M			0.68			0.026
S		8° (max.)				



PLCC20 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	9.78		10.03	0.385		0.395
B	8.89		9.04	0.350		0.356
D	4.2		4.57	0.165		0.180
d1		2.54			0.100	
d2		0.56			0.022	
E	7.37		8.38	0.290		0.330
e		1.27			0.050	
e3		5.08			0.200	
F		0.38			0.015	
G			0.101			0.004
M		1.27			0.050	
M1		1.14			0.045	



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